

AO6401 30V P-Channel MOSFET

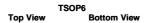
General Description

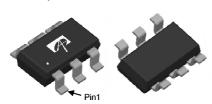
The AO6401 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications.

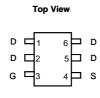
Product Summary

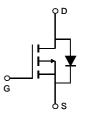
 $\begin{array}{lll} V_{DS} & -30V \\ I_{D} \; (at \; V_{GS} \!\!=\! \!\! -10V) & -5A \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! \!\! -10V) & < 47m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! \!\! -4.5V) & < 64m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! \!\!\! -2.5V) & < 85m\Omega \end{array}$











Absolute Maximum Ratings T_A=25℃ unless otherwise noted

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Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V _{DS}	-30	V			
Gate-Source Voltage		V_{GS}	±12	V			
Continuous Drain	T _A =25℃		-5				
Current	T _A =70℃	ID	-4	A			
Pulsed Drain Current ^c		I _{DM}	-28				
	T _A =25℃	В	2	W			
Power Dissipation ^B T _A =70℃		P _D	1.3	VV			
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C			

Thermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient ^A	t ≤ 10s	D	47.5	62.5	℃/W			
Maximum Junction-to-Ambient AD	Steady-State $R_{\theta JA}$		74	110	°C/W			
Maximum Junction-to-Lead Steady-State		$R_{\theta JL}$	37	50	℃/W			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =-250μA, V _{GS} =0V	-30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-30V, V _{GS} =0V T _J =55℃			-1 -5	μΑ
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±12V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=-250\mu A$	-0.5	-0.9	-1.3	V
I _{D(ON)}	On state drain current	V _{GS} =-10V, V _{DS} =-5V	-28			Α
B(GIV)	Static Drain-Source On-Resistance	V _{GS} =-10V, I _D =-5A		39	47	
		T _J =125℃		60	74	mΩ
		V _{GS} =-4.5V, I _D =-4A		45	64	mΩ
		V _{GS} =-2.5V, I _D =-1A		59	85	mΩ
g _{FS}	Forward Transconductance	V_{DS} =-5V, I_{D} =-5A		18		S
V_{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V		-0.7	-1	V
I _S	Maximum Body-Diode Continuous Current				-2.5	Α
DYNAMIC	PARAMETERS		•	•		
C _{iss}	Input Capacitance			645	780	pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =-15V, f=1MHz		80		pF
C _{rss}	Reverse Transfer Capacitance	7		55	80	pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	4	7.8	12	Ω
SWITCHI	NG PARAMETERS					
Q _g (10V)	Total Gate Charge			14	17	nC
Q _g (4.5V)	Total Gate Charge	V _{GS} =-10V, V _{DS} =-15V, I _D =-5A		7	8.5	nC
Q_{gs}	Gate Source Charge	V _{GS} =-10V, V _{DS} =-15V, I _D =-5A		1.5		nC
Q_{gd}	Gate Drain Charge			2.5		nC
t _{D(on)}	Turn-On DelayTime			6.5		ns
t _r	Turn-On Rise Time	V_{GS} =-10V, V_{DS} =-15V, R_L =3 Ω ,		3.5		ns
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		41		ns
t _f	Turn-Off Fall Time			9		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =-5A, dI/dt=100A/μs		11	13.5	ns
Q_{rr}	Body Diode Reverse Recovery Charge I _F =-5A, dI/dt=100A/μs			3.5		nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on P_D is based on the user's specific board design.

C. Repetitive rating, pulse width limited by junction temperature P_D is based on low frequency and duty cycles to keep

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initial $T_J = 25^{\circ}$ C.

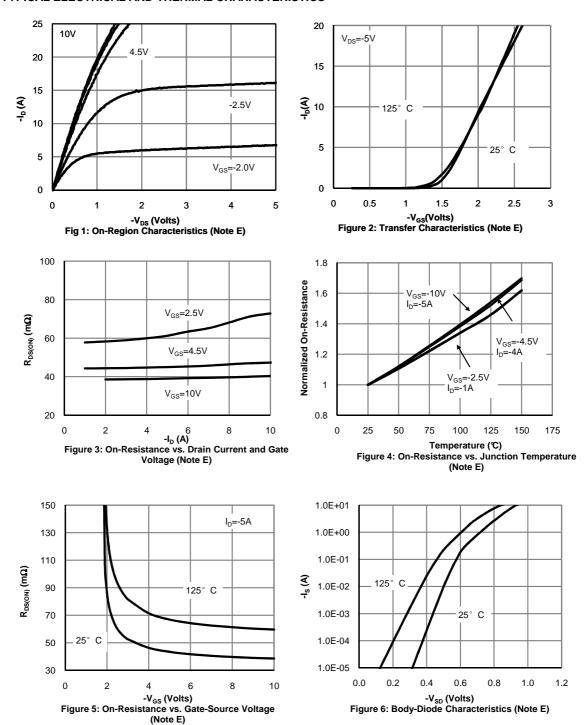
D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(MAX)}=150^\circ$ C. The SOA curve provides a single pulse rating.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



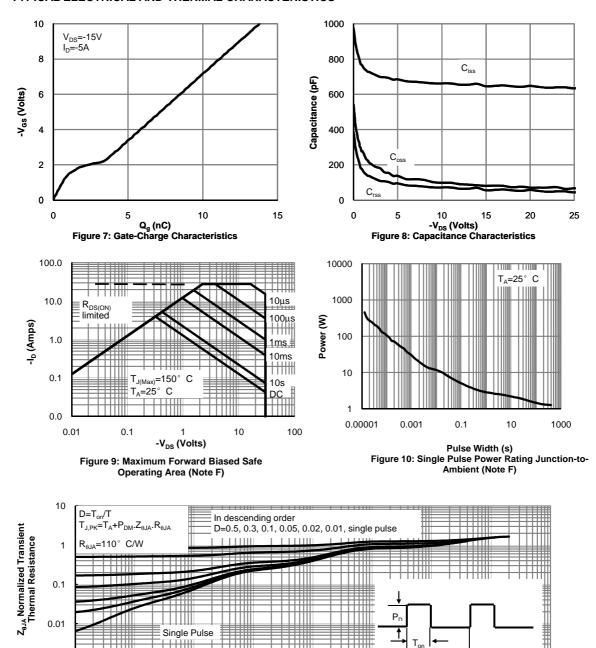


0.0001

0.0001

0.001

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

0.1

10

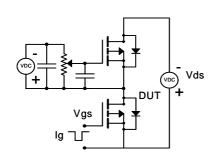
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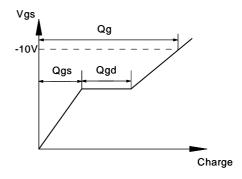
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0.01

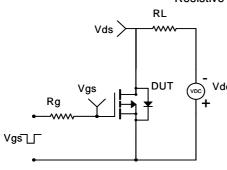


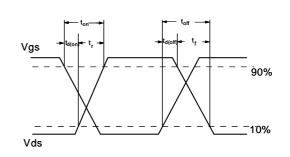
Gate Charge Test Circuit & Waveform



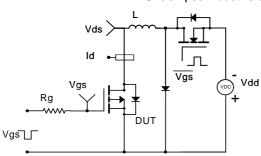


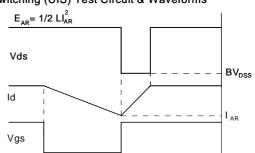
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

